

# 5SNA 1500E450300

## HiPak IGBT Module



- $V_{CE} = 4500\text{ V}$
- $I_C = 1500\text{ A}$
- Ultra-low loss SPT++ technology
- Very soft switching FCE diode with increased diode area
- Exceptional ruggedness and highest current rating
- AISiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance
- Recognized under UL1557, File E 196689

### Maximum rated values <sup>1)</sup>

| Parameter                      | Symbol       | Conditions  | min | max   | Unit               |
|--------------------------------|--------------|---|-----|-------|--------------------|
| Collector-emitter voltage      | $V_{CES}$    | $V_{GE} = 0\text{ V}$   |     | 4500  | V                  |
| DC collector current           | $I_C$        | $T_C = 95\text{ °C}, T_{vj} = 150\text{ °C}$  |     | 1500  | A                  |
| Peak collector current         | $I_{CM}$     | $t_p = 1\text{ ms}$   |     | 3000  | A                  |
| Gate-emitter voltage           | $V_{GES}$    |   | -20 | 20    | V                  |
| DC forward current             | $I_F$        |   |     | 1500  | A                  |
| Peak forward current           | $I_{FRM}$    | $t_p = 1\text{ ms}$   |     | 3000  | A                  |
| Surge current                  | $I_{FSM}$    | $V_R = 0\text{ V}, T_{vj\text{ Start}} = 150\text{ °C},$<br>$t_p = 10\text{ ms, half-sinewave}$                                       |     | 13200 | A                  |
| IGBT short circuit SOA         | $t_{psc}$    | $V_{CC} = 3200\text{ V}, V_{CEM\text{ CHIP}} \leq 4500\text{ V}$<br>$V_{GE} \leq 15\text{ V}, T_{vj\text{ Start}} \leq 150\text{ °C}$ |     | 10    | $\mu\text{s}$      |
| Isolation voltage              | $V_{isol}$   | 1 min, $f = 50\text{ Hz}$   |     | 6000  | V                  |
| Junction temperature           | $T_{vj}$     |   |     | 175   | $^{\circ}\text{C}$ |
| Junction operating temperature | $T_{vj(op)}$ |   | -40 | 150   | $^{\circ}\text{C}$ |
| Case temperature               | $T_C$        |   | -50 | 125   | $^{\circ}\text{C}$ |
| Storage temperature            | $T_{stg}$    |   | -50 | 125   | $^{\circ}\text{C}$ |
| Mounting torques               | $M_s$        | Base-heatsink, M6 screws  | 4   | 6     | Nm                 |
|                                | $M_{t1}$     | Main terminals, M8 screws   | 8   | 10    |                    |
|                                | $M_{t1}$     | Auxiliary terminals, M4 screws  | 2   | 3     |                    |

<sup>1)</sup> Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

IGBT characteristic values <sup>2)</sup>

| Parameter  | Symbol             | Conditions  | min                                  | typ   | max | Unit          |
|--|--------------------|---|--------------------------------------|-------|-----|---------------|
| Collector (-emitter) breakdown voltage             | $V_{(BR)CES}$      | $V_{GE} = 0\text{ V}$ , $I_C = 10\text{ mA}$ , $T_{vj} \geq -40\text{ °C}$  | 4500                                 |       |     | V             |
| Collector-emitter <sup>3)</sup> saturation voltage | $V_{CE\text{sat}}$ | $I_C = 1500\text{ A}$ , $V_{GE} = 15\text{ V}$  | $T_{vj} = 25\text{ °C}$              | 2.7   |     | V             |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 3.55  |     | V             |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 3.80  |     | V             |
| Collector cut-off current                          | $I_{CES}$          | $V_{CE} = 4500\text{ V}$ , $V_{GE} = 0\text{ V}$  | $T_{vj} = 25\text{ °C}$              |       | 1   | mA            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 20    |     | mA            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 105   |     | mA            |
| Gate leakage current                               | $I_{GES}$          | $V_{CE} = 0\text{ V}$ , $V_{GE} = \pm 20\text{ V}$ , $T_{vj} = 150\text{ °C}$   | -500                                 |       | 500 | nA            |
| Gate-emitter threshold voltage                     | $V_{GE(TO)}$       | $I_C = 240\text{ mA}$ , $V_{CE} = V_{GE}$ , $T_{vj} = 25\text{ °C}$   | 4.5                                  |       | 6.5 | V             |
| Gate charge  | $Q_{ge}$           | $I_C = 1500\text{ A}$ , $V_{CE} = 2800\text{ V}$ , $V_{GE} = -15\text{ V} \dots +15\text{ V}$   |                                      | 10.85 |     | $\mu\text{C}$ |
| Input capacitance                                  | $C_{ies}$          |   |                                      | 305   |     | nF            |
| Internal gate resistance                           | $R_{Gint}$         |   |                                      | 0.74  |     | $\Omega$      |
| Turn-on delay time                                 | $t_{d(on)}$        | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 1.5\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 510   |     | ns            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 510   |     | ns            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 510   |     | ns            |
| Rise time  | $t_r$              | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 1.5\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 200   |     | ns            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 220   |     | ns            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 230   |     | ns            |
| Turn-off delay time                                | $t_{d(off)}$       | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 6.8\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 3260  |     | ns            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 3550  |     | ns            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 3650  |     | ns            |
| Fall time  | $t_f$              | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 6.8\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 560   |     | ns            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 590   |     | ns            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 650   |     | ns            |
| Turn-on switching energy                           | $E_{on}$           | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 1.5\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 4000  |     | mJ            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 5330  |     | mJ            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 5860  |     | mJ            |
| Turn-off switching energy                          | $E_{off}$          | $V_{CC} = 2800\text{ V}$ , $I_C = 1500\text{ A}$ ,<br>$R_G = 6.8\ \Omega$ , $C_{GE} = 220\text{ nF}$ ,<br>$V_{GE} = \pm 15\text{ V}$ ,<br>$L_\sigma = 150\text{ nH}$ , inductive load | $T_{vj} = 25\text{ °C}$              | 4820  |     | mJ            |
|  |                    |   | $T_{vj} = 125\text{ °C}$             | 5620  |     | mJ            |
|  |                    |   | $T_{vj} = 150\text{ °C}$             | 5900  |     | mJ            |
| Short circuit current                              | $I_{SC}$           | $t_{psc} \leq 10\ \mu\text{s}$ , $V_{GE} = 15\text{ V}$ ,<br>$V_{CC} = 3200\text{ V}$ ,<br>$V_{CEM\text{CHIP}} \leq 4500\text{ V}$  | $T_{vj\text{Start}} = 150\text{ °C}$ | 7800  |     | A             |

<sup>2)</sup> Characteristic values according to IEC 60747 – 9<sup>3)</sup> Collector-emitter saturation voltage is given at chip level

Diode characteristic values <sup>4)</sup>

| Parameter                     | Symbol    | Conditions  | min                       | typ  | max | Unit          |
|-------------------------------|-----------|---|---------------------------|------|-----|---------------|
| Forward voltage <sup>5)</sup> | $V_F$     | $I_F = 1500 \text{ A}$  | $T_{vj} = 25 \text{ °C}$  | 2.55 |     | V             |
|                               |           |   | $T_{vj} = 125 \text{ °C}$ | 2.80 |     | V             |
|                               |           |   | $T_{vj} = 150 \text{ °C}$ | 2.75 |     | V             |
| Reverse recovery current      | $I_{rr}$  |   | $T_{vj} = 25 \text{ °C}$  | 1900 |     | A             |
|                               |           |   | $T_{vj} = 125 \text{ °C}$ | 2250 |     | A             |
|                               |           |   | $T_{vj} = 150 \text{ °C}$ | 2370 |     | A             |
| Recovered charge              | $Q_{rr}$  | $V_{CC} = 2800 \text{ V},$<br>$I_F = 1500 \text{ A},$<br>$V_{GE} = \pm 15 \text{ V},$<br>$R_G = 1.5 \text{ } \Omega,$<br>$C_{GE} = 220 \text{ nF},$<br>$L_G = 150 \text{ nH}$<br>inductive load | $T_{vj} = 25 \text{ °C}$  | 1570 |     | $\mu\text{C}$ |
|                               |           |   | $T_{vj} = 125 \text{ °C}$ | 2480 |     | $\mu\text{C}$ |
|                               |           |   | $T_{vj} = 150 \text{ °C}$ | 2880 |     | $\mu\text{C}$ |
| Reverse recovery time         | $t_{rr}$  |   | $T_{vj} = 25 \text{ °C}$  | 1320 |     | ns            |
|                               |           |   | $T_{vj} = 125 \text{ °C}$ | 1780 |     | ns            |
|                               |           |   | $T_{vj} = 150 \text{ °C}$ | 1930 |     | ns            |
| Reverse recovery energy       | $E_{rec}$ |   | $T_{vj} = 25 \text{ °C}$  | 2730 |     | mJ            |
|                               |           |   | $T_{vj} = 125 \text{ °C}$ | 4500 |     | mJ            |
|                               |           |   | $T_{vj} = 150 \text{ °C}$ | 5350 |     | mJ            |

<sup>4)</sup> Characteristic values according to IEC 60747 – 2<sup>5)</sup> Forward voltage is given at chip levelPackage properties <sup>6)</sup>

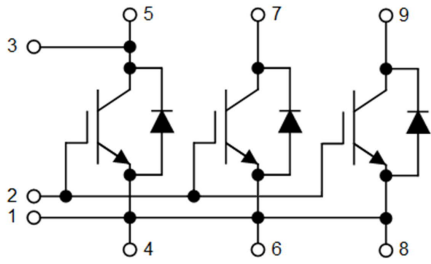
| Parameter   | Symbol             | Conditions   | min                    | typ   | max    | Unit       |
|---|--------------------|--|------------------------|-------|--------|------------|
| IGBT thermal resistance junction to case                | $R_{th(j-c)IGBT}$  |  |                        |       | 0.0098 | K/W        |
| Diode thermal resistance junction to case               | $R_{th(j-c)DIODE}$ |  |                        |       | 0.016  | K/W        |
| IGBT thermal resistance <sup>2)</sup> case to heatsink  | $R_{th(c-s)IGBT}$  | IGBT per switch, $\lambda$ grease = 1W/m x K                     |                        | 0.008 |        | K/W        |
| Diode thermal resistance <sup>2)</sup> case to heatsink | $R_{th(c-s)DIODE}$ | Diode per switch, $\lambda$ grease = 1W/m x K                    |                        | 0.011 |        | K/W        |
| Partial discharge voltage                               | $V_e$              | $f = 50 \text{ Hz}, Q_{PD} \leq 10\text{pC}$ (acc. to IEC 61287) | 3500                   |       |        | V          |
| Comparative tracking index                              | CTI                |  | 600                    |       |        | V          |
| Module stray inductance                                 | $L_{\sigma CE}$    |  |                        | 18    |        | nH         |
| Resistance, terminal-chip                               | $R_{CC+EE}$        |  | $T_C = 25 \text{ °C}$  | 0.055 |        | m $\Omega$ |
|   |                    |  | $T_C = 125 \text{ °C}$ | 0.075 |        |            |
|   |                    |  | $T_C = 150 \text{ °C}$ | 0.080 |        |            |

Mechanical properties <sup>6)</sup>

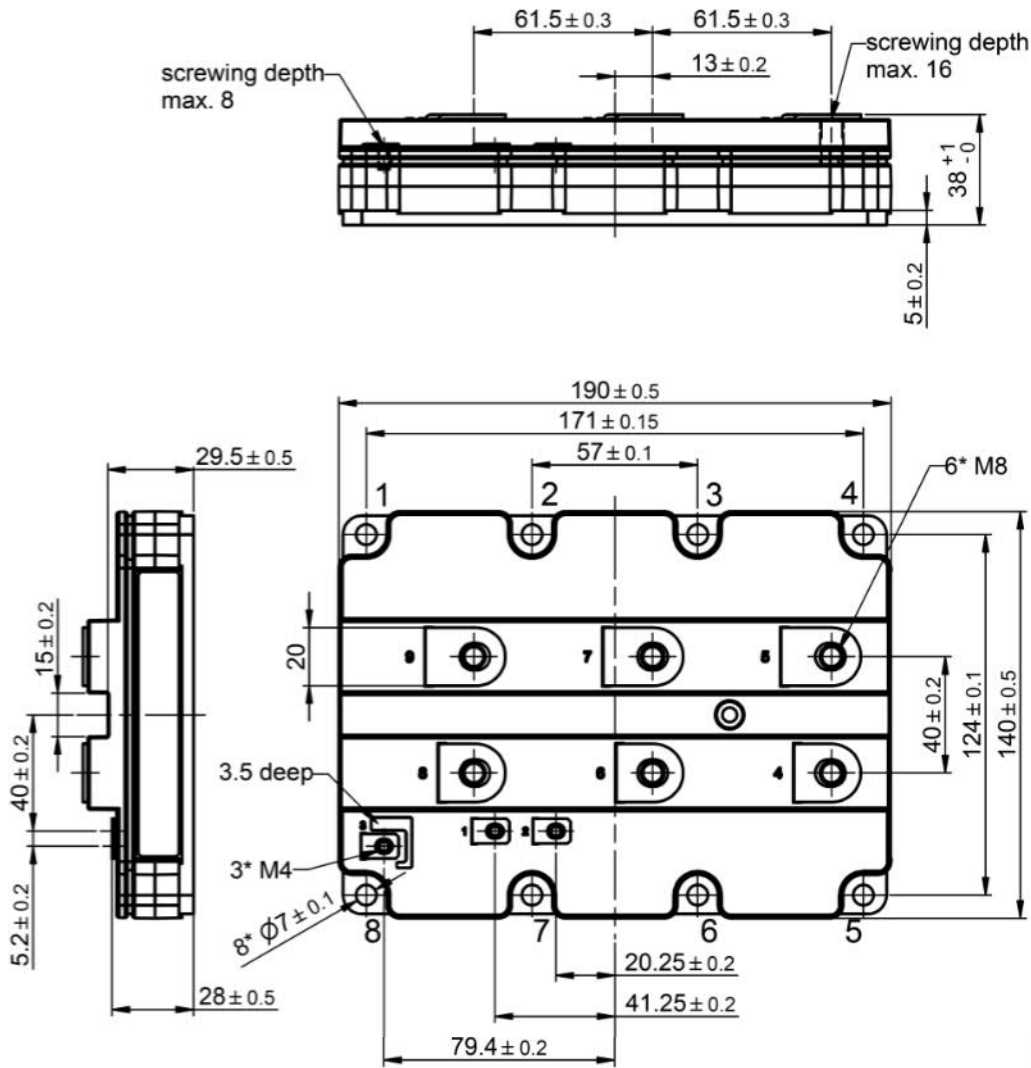
| Parameter                 | Symbol    | Conditions                              | min            | typ            | max | Unit |
|---------------------------|-----------|---|----------------|----------------|-----|------|
| Dimensions                | L x W x H | Typical                                 |                | 190 x 140 x 38 |     | mm   |
| Clearance distance in air | $d_a$     | According to IEC 60664-1 and EN 50124-1 | Term. to base: | 23             |     | mm   |
|                           |           |   | Term. to term: | 19             |     |      |
| Surface creepage distance | $d_s$     | According to IEC 60664-1 and EN 50124-1 | Term. to base: | 28.2           |     | mm   |
|                           |           |   | Term. to term: | 28.2           |     |      |
| Mass                      | m         |   |                | 1190           |     | g    |

<sup>6)</sup> Package and mechanical properties according to IEC 60747 – 15

Electrical configuration



Outline drawing (mm)



Note: This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. VIII. This product has been designed and qualified for Industrial Level.

Fig. 1 Typical on-state characteristics, chip level

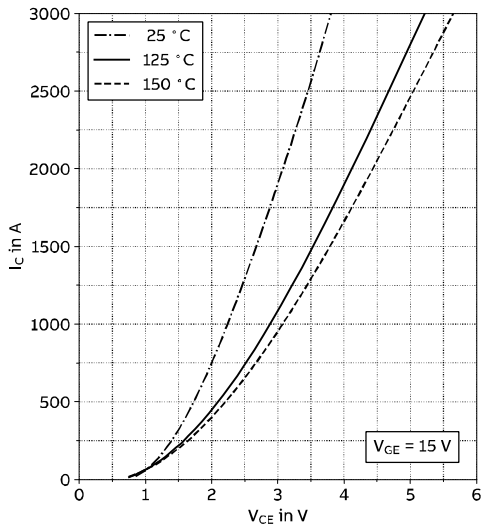


Fig. 2 Typical transfer characteristics, chip level

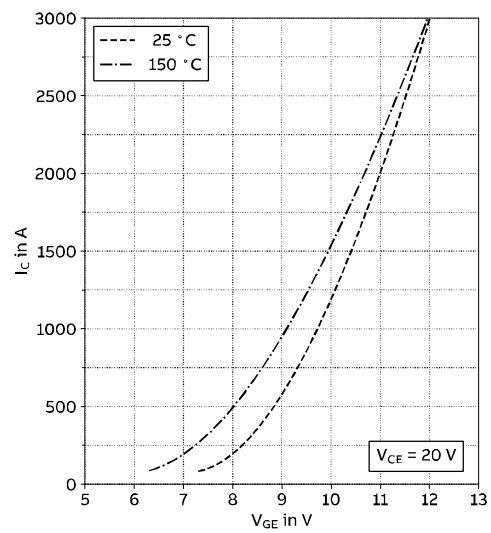


Fig. 3 Typical output characteristics, chip level, VGE = 15 V

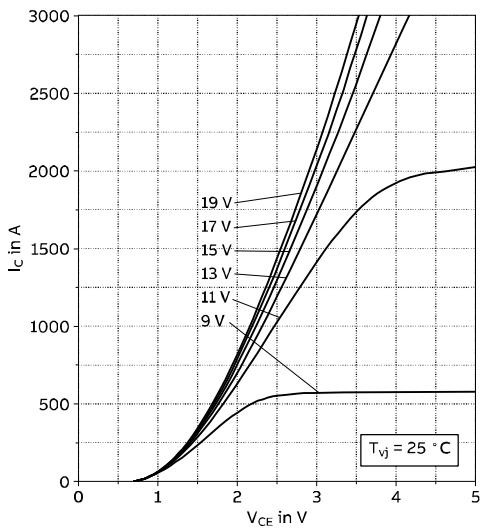


Fig. 4 Typical output characteristics, chip level, VGE = 15 V

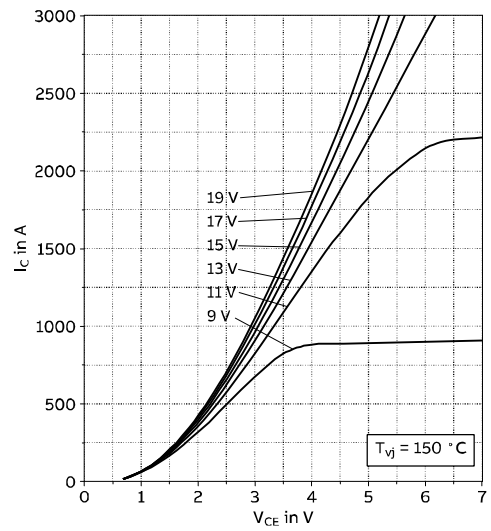


Fig. 5 Typical switching energies per pulse vs. collector current

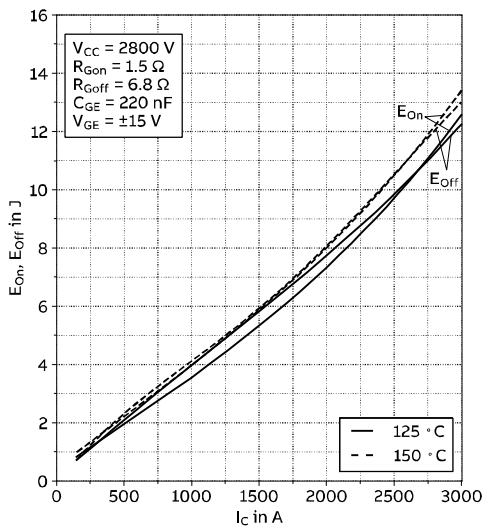


Fig. 6 Typical switching energies per pulse vs. gate resistor

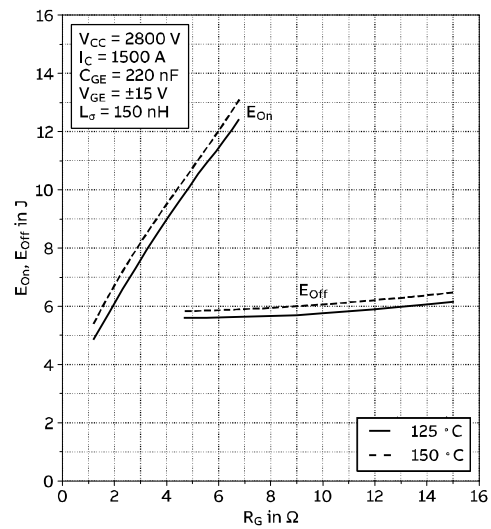


Fig. 7 Typical switching times vs. collector current

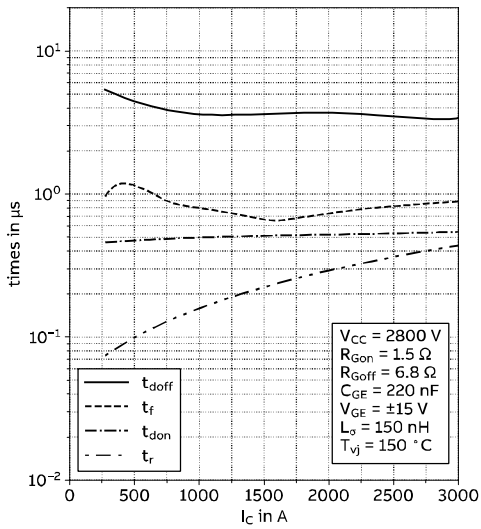


Fig. 8 Typical switching times vs. gate resistor

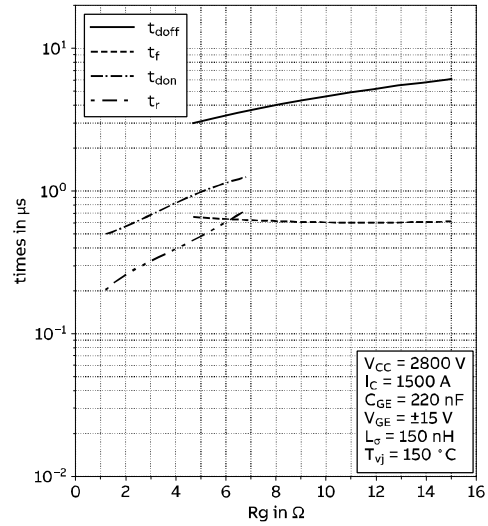


Fig. 9 Typical gate charge characteristics

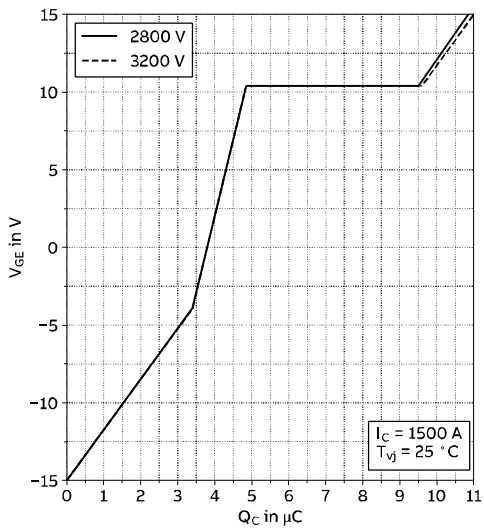


Fig. 10 Turn-off safe operating area (RBSOA)

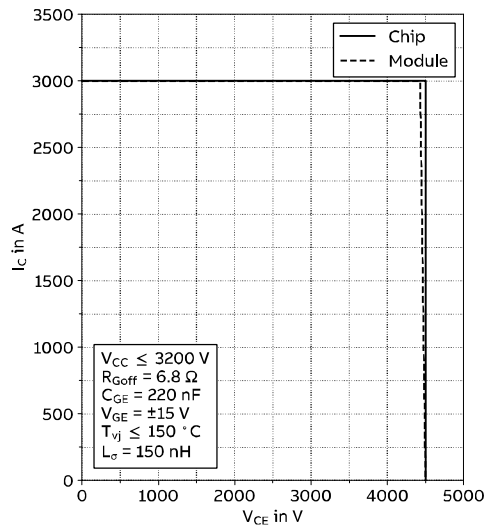


Fig. 11 Typical diode forward characteristics chip level

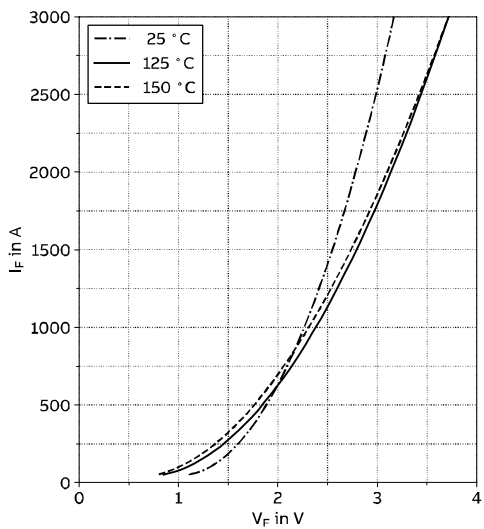


Fig. 12 Typical reverse recovery characteristics vs. forward current

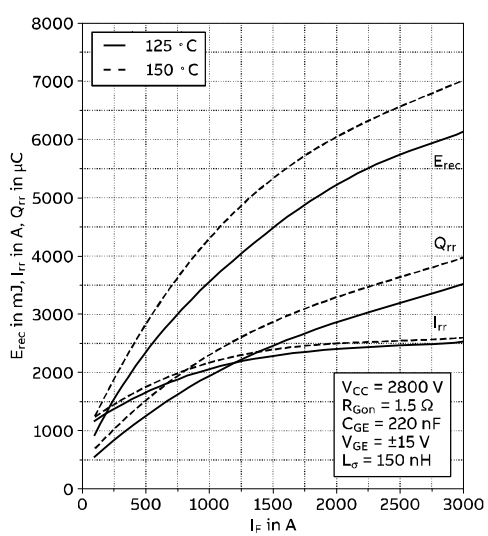


Fig. 13 Typical reverse recovery characteristics vs. di/dt

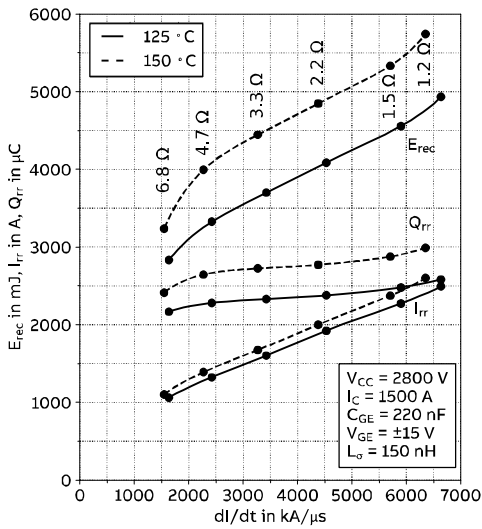


Fig. 14 Safe operating area diode (SOA)

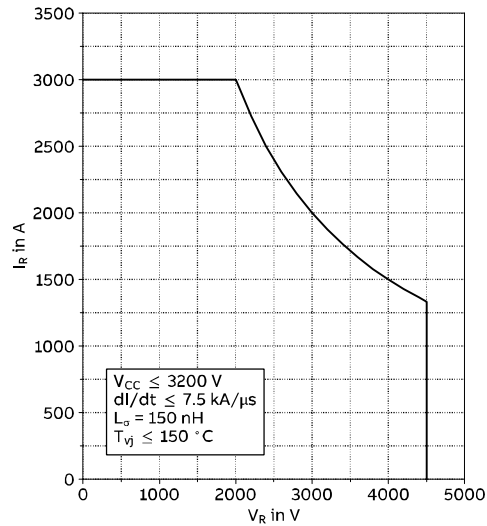
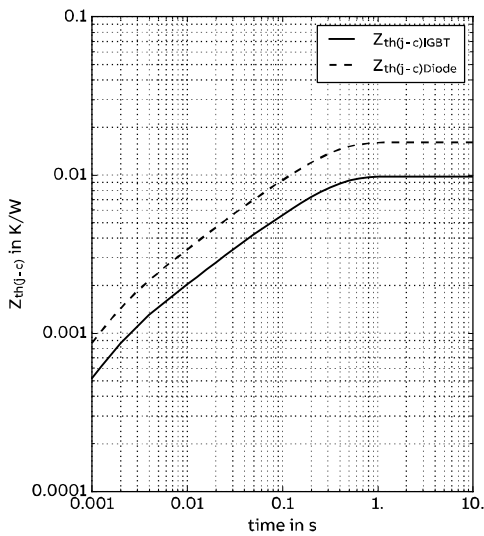


Fig. 15 Thermal impedance vs. time



Analytical function of the transient thermal resistance

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/\tau_i})$$

|       |                       |      |      |      |      |   |
|-------|-----------------------|------|------|------|------|---|
|       | i                     | 1    | 2    | 3    | 4    | 5 |
| IGBT  | R <sub>i</sub> (K/kW) | 0.9  | 2.35 | 4.84 | 1.68 |   |
|       | τ <sub>i</sub> (ms)   | 3609 | 364  | 51   | 3.7  |   |
| DIODE | R <sub>i</sub> (K/kW) | 1.95 | 6.11 | 5.9  | 2.06 |   |
|       | τ <sub>i</sub> (ms)   | 2283 | 160  | 32   | 2.7  |   |

Related documents:

- 5SYA 2039 Mounting Instructions for HiPak modules
- 5SYA 2042 Failure rates of HiPak modules due to cosmic rays
- 5SYA 2043 Load – cycle capability of HiPaks
- 5SYA 2045 Thermal runaway during blocking
- 5SYA 2053 Applying IGBT
- 5SYA 2058 Surge currents for IGBT diodes
- 5SYA 2093 Thermal design of IGBT modules
- 5SYA 2098 Paralleling of IGBT modules
- 5SZK 9111 Specification of environmental class for HiPak Storage
- 5SZK 9118 General Environmental Conditions For High Power Semiconductors
- 5SZK 9120 Specification of environmental class for HiPak

ABB Power Grids Switzerland Ltd, Semiconductors  
A Hitachi ABB Joint Venture

Fabrikstrasse 3  
CH-5600 Lenzburg  
Switzerland

www.hitachiabb-powergrids.com/semiconductors

We reserve all rights in this document and in the subject matter and illustrations contained therein. Any reproduction, disclosure to third parties or utilization of its contents – in whole or in parts – is forbidden without prior written consent. Copyright 2021 Hitachi Power Grids. All rights reserved.